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Optical Metrology Solutions for the Semiconductor and Microelectronic Industries

Wednesday, July 31, 2019 11:00 AM - 12:00 PM EDT

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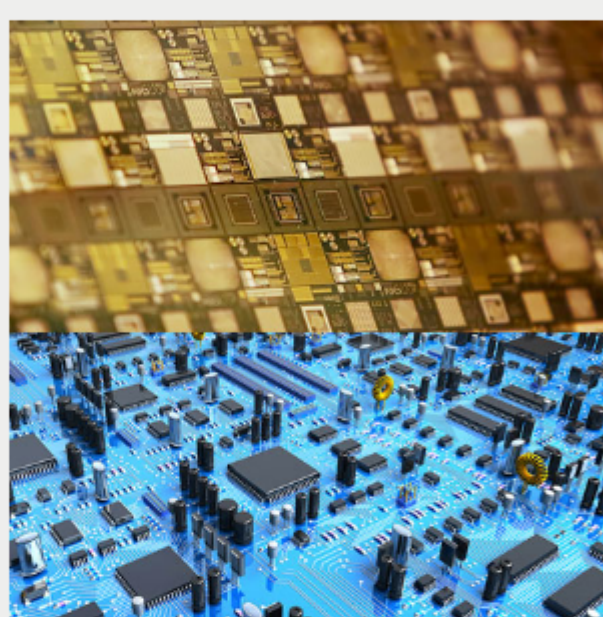
Presented by

SENSOFAR[®]
METROLOGY

About This Webinar

This webinar will discuss specific analysis for quality control in PCB applications. It will also cover critical dimensional measurement, roughness, and defect identification. Presenters Adam Platteis and Alberto Aguerri will show solutions pertaining to ISO 4287, ISO 25178, and how Sensofar's proprietary software quickly identifies profiles, roughness parameters, and defects for surface texture, height, and traces. The focus will be on imaging wafers, pads, step heights, bonds, and probe cards.

Sensofar solutions can be used in the R&D lab and for in-line QA/QC high-throughput environments for automatic Pass/Fail reporting. Sensofar offers standalone and customizable solutions that integrate confocal, interferometry, and focus variation technologies into a single sensor-head for the semiconductor and microelectronic industries.



About the presenters:

Adam Platteis, a graduate of York College, joined Sensofar in 2018 as the company's U.S. sales director. Before joining Sensofar, Platteis spent 10 years with Carl Zeiss Microscopy, providing solutions to the semiconductor, microelectronics, and other industrial markets.

Alberto Aguerri is the global sales manager for Sensofar Metrology. He has worked for Sensofar for more than 10 years in various company positions. Before joining Sensofar, he worked for several years as an application engineer in fields related to optical metrology. Aguerri holds a MSc in Photonics from Polytechnic University of Catalonia (UPC).

Who should attend:

This webinar is for R&D managers, lab technicians, QA and QC professionals, inspection managers, engineers, process integrators, wafer technicians, as well as anyone involved in failure analysis and/or material analysis. Professionals working in the semiconductor and microelectronics fields will benefit from this webinar, as well as those involved in precision optics, data storage, display technologies, and film and material technologies.

About Sensofar:

Sensofar is a leading-edge technology company that has the highest quality standards within the field of surface metrology. Sensofar Metrology provides high-accuracy optical profilers based on confocal, interferometry, and focus variation techniques, from standard setups for R&D and quality inspection laboratories to complete non-contact metrology solutions for in-line production processes. The Sensofar headquarters are located in Barcelona and the Group is represented in over 30 countries, with sales offices in Asia, United States, and Germany.

Mark Your Calendar

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SYSTEM REQUIREMENTS

PC-based attendees

Required: Windows[®] 10, 8, 7, Vista, XP or 2003 Server

Mac[®] -based attendees

Required: Mac OS[®] X 10.6 or newer

Mobile attendees

Required: iPhone[®], iPad[®], Android[™] phone or tablet, Windows 8 or Windows Phone 8

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